

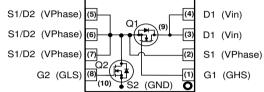
Power Block

Features

- Dual asymmetric N-channel OptiMOS™5 MOSFET
- Logic level (4.5V rated)
- Optimized for high performance buck converters
- Qualified according to JEDEC¹⁾ for target applications
- Pb-free lead plating; RoHS compliant
- Halogen-free according to IEC61249-2-21

Product Summary

		Q1	Q2	
$V_{ t DS}$		25	25	>
$R_{ extsf{DS(on)}, extsf{max}}$	<i>V</i> _{GS} =10 V	3	0.8	mΩ
	V _{GS} =4.5 V	4	1.1	
I _D		50	50	Α



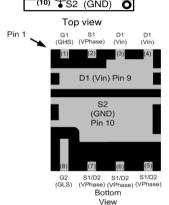






Туре	Package	Marking
BSG0811ND	PG-TISON8-4	0811ND

Maximum ratings, at $T_{\rm j}$ =25 °C, unless otherwise specified ²⁾



Parameter	Symbol	Conditions	Va	lue	Unit
Tarameter	Joynibor	Conditions	Q1		
Continuous drain current	I _D	T _C =70 °C, V _{GS} =10 V	50	50	Α
		T _C =70 °C, V _{GS} =4.5 V	50	50	Maria A A Maria Mania Maria Ma
		T _A =25 °C, V _{GS} =4.5 V ³⁾	31	50	
		T _A =25 °C, V _{GS} =4.5 V ⁴⁾	19	41	
Pulsed drain current	I _{D,pulse}	T _C =70 °C	160	160	
Avalanche energy, single pulse	E _{AS}	Q1: I_D =10 A, Q2: I_D =20 A, R_{GS} =25 Ω	30	160	mJ
Gate source voltage	V_{GS}		±16		V
Power dissipation	P_{tot}	T _A =25 °C ³⁾	6.25	6.25	W
		T _A =25 °C ⁴⁾	2.5	2.5	
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 150		°C
IEC climatic category; DIN IEC 68-1			55/1	50/56	
1) LSTD20 and JESD22					

¹⁾ J-STD20 and JESD22



Parameter		Symbol	Conditions	Values			Unit
				min.	typ.	max.	
Thermal characteristics							
Thermal resistance, junction - case	Q1	$R_{ m thJC}$		-	-	4.3	K/W
	Q2			-	-	1.8]
Thermal resistance, junction - ambient ²⁾	Q1 Q2	-	application specific board ³⁾	-	-	20	
	Q1		6 cm ² cooling area ⁴⁾	_	_	50	1
	Q2		o cini cooling area		_	30	

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	Q1 Q2	$V_{(BR)DSS}$	$V_{\rm GS}$ =0 V, $I_{\rm D}$ =1 mA	25 ⁶⁾	-	-	V
Gate threshold voltage	Q1 Q2	$V_{GS(th)}$	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 250 \mu {\rm A}$	1.2	1.6	2	
Zero gate voltage drain current	Q1 Q2	I _{DSS}	$V_{\rm DS}$ =25 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =25 °C	-	-	1	μА
	Q1 Q2		$V_{\rm DS}$ =25 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =150 °C	-	-	100	
Gate-source leakage current	Q1 Q2	I _{GSS}	V _{GS} =20 V, V _{DS} =0 V	-	-	100	nA
Drain-source on-state	Q1	$R_{\mathrm{DS(on)}}$	V _{GS} =4.5 V, I _D =20 A	-	3.2	4.0	mΩ
resistance	Q2		V _{GS} =4.5 V, I _D =20 A	1	0.9	1.1	
	Q1		V _{GS} =10 V, I _D =20 A	1	2.4	3.0	
	Q2		V GS=10 V, 7D=20 A	ı	0.7	0.8	
Gate resistance	Q1	R_{G}		1	0.7	1.2	Ω
	Q2			1	0.7	1.2	
Transconductance	Q1	g_{fs}	$ V_{\rm DS} > 2 I_{\rm D} R_{\rm DS(on)max}$	46	93	-	S
			I _D =20 A	90	180	-	

²⁾ Only one of both transistors active

³⁾ 8 Layers copper 70μm thickness. PCB in still air.

⁴⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.



Parameter		Symbol	Conditions	Values		Uni	
				min.	typ.	max.	
Dynamic characteristics							
Input capacitance	Q1	C_{iss}		-	780	1100	рF
	Q2			-	2700	3700	
Output capacitance	Q1	Coss	V _{GS} =0 V,	-	390	520	
	Q2		V_{DS} = 12 V, f =1 MHz	-	1400	1900	
Reverse transfer capacitance	Q1	C _{rss}		-	38	-	
	Q2			-	130	-	
Turn-on delay time	Q1	$t_{d(on)}$		-	4.3		ns
	Q2			-	5.6	-	
-	Q1	t _r	V _{IN} =12 V,	-	4.7	-	
	Q2		V _{DRV} =5 V, F _{SW} =500 KHz,	-	4.3	-	
Turn-off delay time	Q1	$t_{d(off)}$	I _{OUT} =30 A ⁵⁾	-	4.3	-	
	Q2			-	8.8	-	
Fall time	Q1	t _f		-	1.4	-	
	Q2			-	2.6	-	
Gate Charge Characteristics							
Gate to source charge	Q1	Q_{gs}		-	2.0	-	nC
Gate to drain charge		Q_{gd}		-	1.4	-	1
Gate charge total		Q_{g}		-	5.6	8.4	1
Gate plateau voltage		V _{plateau}	V _{DD} =12 V, V _D =30 A,	-	2.6	-	٧
Gate to source charge	Q2	Q_{gs}	$V_{\rm GS} = 0 \text{ to } 4.5 \text{ V}$	-	6.4	-	nC
Gate to drain charge		Q_{gd}		-	4.7	-	
Gate charge total		Q_{g}		-	20	29	
Gate plateau voltage		V _{plateau}		-	2.3	-	٧
Output charge	Q1	$Q_{\rm oss}$	V 10 V V 0 V	-	8	-	nC
	Q2	1	$V_{\rm DD}$ =12 V, $V_{\rm GS}$ =0 V	-	27	-	

⁵⁾ For more information see application note n° TBD

The device can withstand a pulse of not more than 30 V for a duration of up to 2 ns at a frequency of 600 kHz with maximum buck converter input voltage $V_{\rm IN}$ =16 V.



Parameter	s	Symbol	Conditions	Values		Unit	
				min.	typ.	max.	
Reverse Diode							
Diode continuous forward current	Q1 /s	S		-	-	29	Α
	Q2		. T _c =25 °C	-	-	50	
Diode pulse current	Q1 /	S,pulse	7 _C =23 0	-	-	160	
	Q2			-	-	160	
Diode forward voltage	Q1 <i>V</i>	/ _{SD}	V _{GS} =0 V, I _F =20 A,	-	0.84	1	٧
	Q2		T _j =25 °C	-	0.77	1	
Reverse recovery charge	Q1 C	$Q_{\rm rr}$ $V_{\rm R}=12 \text{ V}, I_{\rm F}=I_{\rm S},$ $di_{\rm F}/dt=100 \text{ A/}\mu\text{s}$	-	10	-	nC	
	Q2		-	20	-		

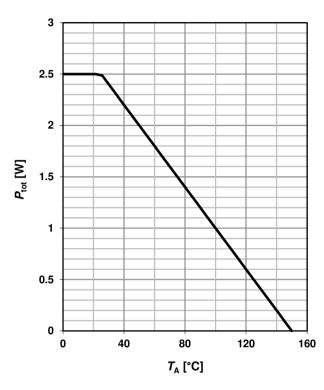


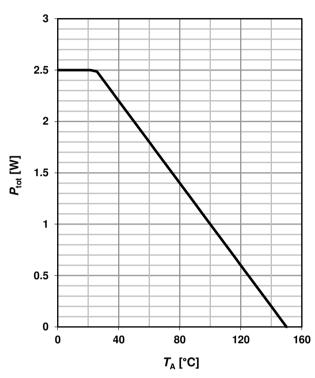
1 Power dissipation (Q1)

$P_{\text{tot}} = f(T_A)^{4)}$

2 Power dissipation (Q2)

$$P_{\text{tot}} = f(T_A)^{4)}$$





3 Drain current (Q1)

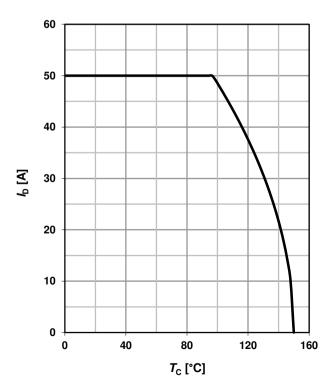
 I_{D} =f(T_{C})

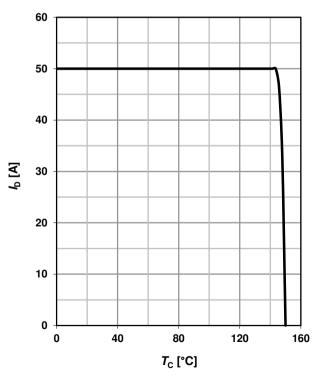
parameter: V_{GS}≥10 V

4 Drain current (Q2)

 I_{D} =f(T_{C})

parameter: V_{GS}≥10 V



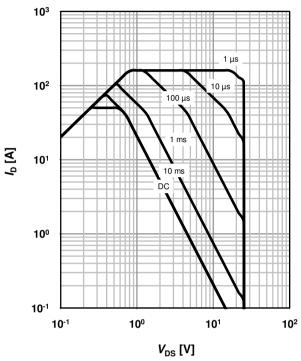




5 Safe operating area (Q1)

 $I_{D}=f(V_{DS}); T_{C}=25 \text{ °C}; D=0$

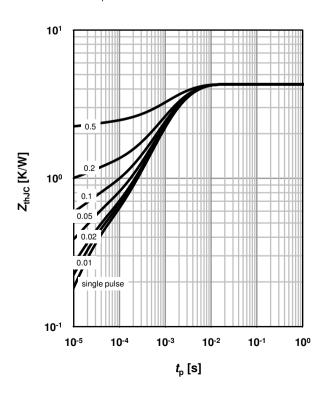
parameter: t_p



7 Max. transient thermal impedance (Q1)

 $Z_{\text{thJC}} = f(t_{p})$

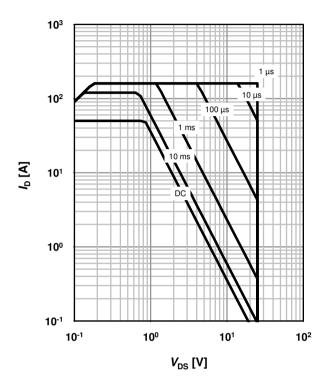
parameter: $D=t_p/T$



6 Safe operating area (Q2)

 $I_{D}=f(V_{DS}); T_{C}=25 \text{ °C}; D=0$

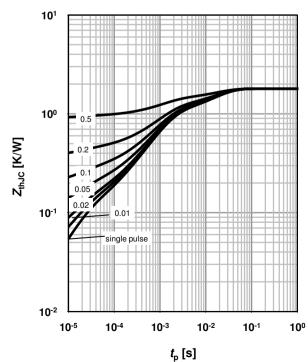
parameter: t_p



8 Max. transient thermal impedance (Q2)

 $Z_{\text{thJC}} = f(t_p)$

parameter: $D=t_p/T$

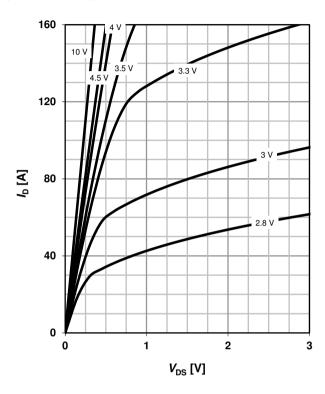




9 Typ. output characteristics (Q1)

 $I_D=f(V_{DS}); T_j=25 \text{ °C}$

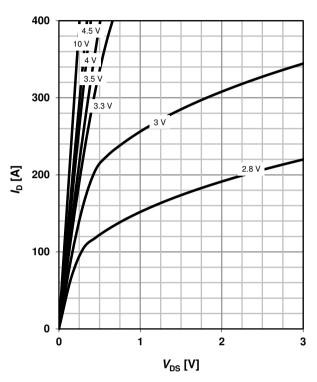
parameter: $V_{\rm GS}$



10 Typ. output characteristics (Q2)

 $I_D=f(V_{DS}); T_i=25 \text{ °C}$

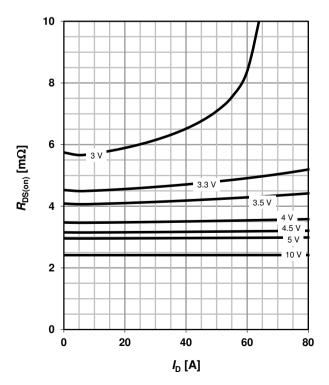
parameter: V_{GS}



11 Typ. drain-source on resistance (Q1)

 $R_{DS(on)}=f(I_D); T_j=25 °C$

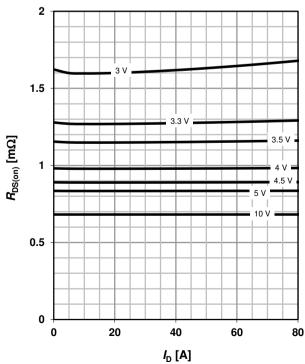
parameter: V_{GS}



12 Typ. drain-source on resistance (Q2)

 $R_{DS(on)}=f(I_D); T_j=25 \text{ °C}$

parameter: V_{GS}

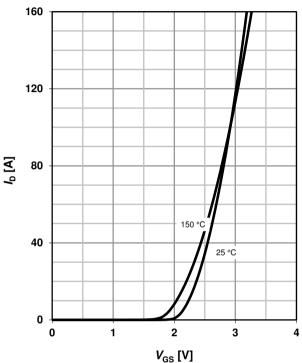




13 Typ. transfer characteristics (Q1)

 $I_{D}=f(V_{GS}); |V_{DS}|>2 |I_{D}| R_{DS(on)max}$

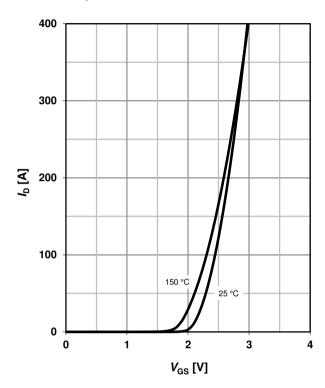
parameter: T_i



14 Typ. transfer characteristics (Q2)

 $I_{D}=f(V_{GS}); /V_{DS} > 2 | I_{D}/R_{DS(on)max}$

parameter: T_i

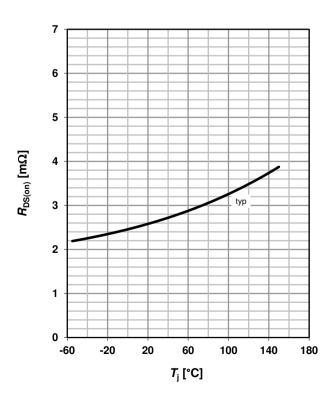


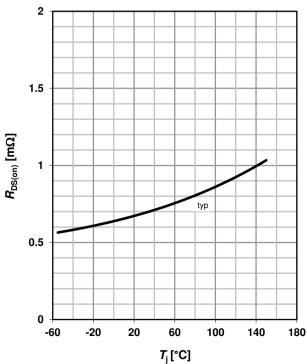
15 Drain-source on-state resistance (Q1)

 $R_{DS(on)}$ =f(T_j); I_D =20 A; V_{GS} =10 V



$$R_{DS(on)}=f(T_j); I_D=20 A; V_{GS}=10 V$$





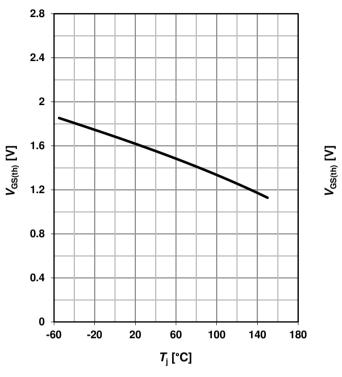


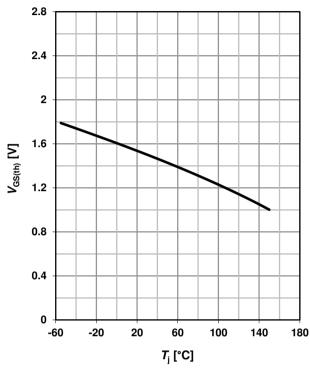
17 Typ. gate threshold voltage (Q1)

$V_{GS(th)} = f(T_i); V_{GS} = V_{DS}; I_D = 250 \mu A$

18 Typ. gate threshold voltage (Q2)

$$V_{GS(th)} = f(T_i); V_{GS} = V_{DS}; I_D = 250 \mu A$$



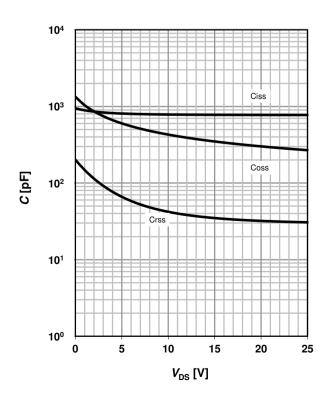


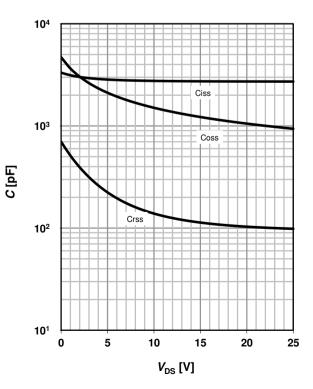
19 Typ. capacitances (Q1)

$$C=f(V_{DS}); V_{GS}=0 V; f=1 MHz$$

20 Typ. capacitances (Q2)

$$C=f(V_{DS}); V_{GS}=0 V; f=1 MHz$$



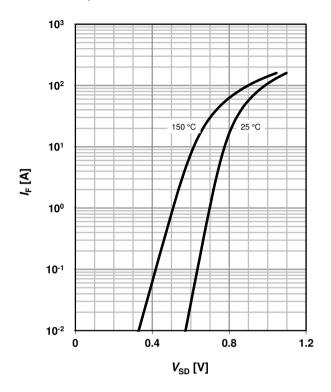




21 Forward characteristics of reverse diode (Q1) 22 Forward characteristics of reverse diode (Q2)

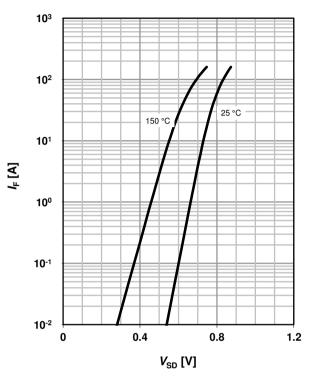
$I_{\mathsf{F}} = \mathsf{f}(V_{\mathsf{SD}})$

parameter: T_i



 $I_{\mathsf{F}} = \mathsf{f}(V_{\mathsf{SD}})$

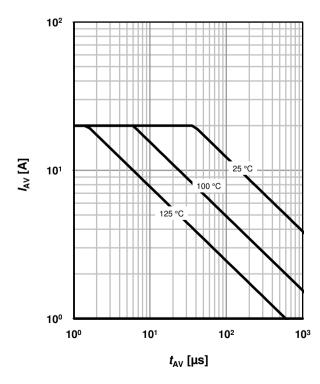
parameter: T_i



23 Avalanche characteristics (Q1)

 I_{AS} =f(t_{AV}); R_{GS} =25 Ω

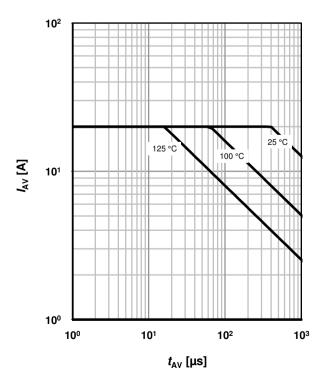
parameter: T_{j(start)}



24 Avalanche characteristics (Q2)

 I_{AS} =f(t_{AV}); R_{GS} =25 Ω

parameter: $T_{j(start)}$

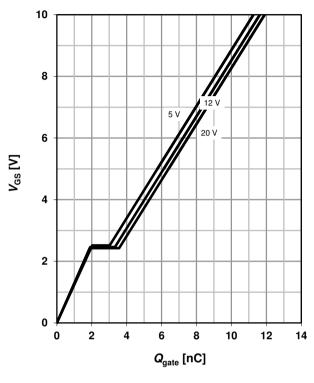




25 Typ. gate charge (Q1)

 V_{GS} =f(Q_{gate}); I_D =20 A pulsed

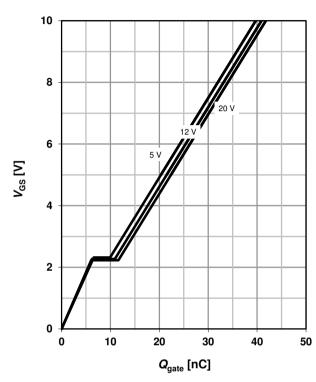
parameter: $V_{\rm DD}$



26 Typ. gate charge (Q2)

 V_{GS} =f(Q_{gate}); I_{D} =20 A pulsed

parameter: $V_{\rm DD}$

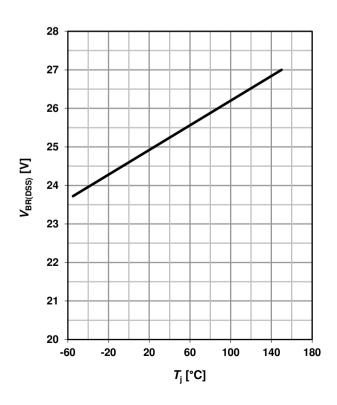


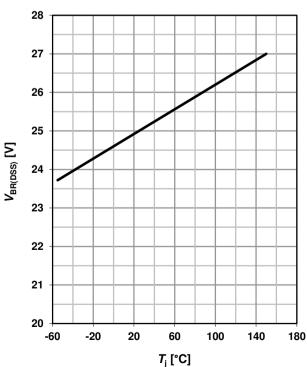
27 Drain-source breakdown voltage (Q1)

 $V_{BR(DSS)}=f(T_j); I_D=1 \text{ mA}$



 $V_{BR(DSS)}=f(T_j); I_D=1 \text{ mA}$

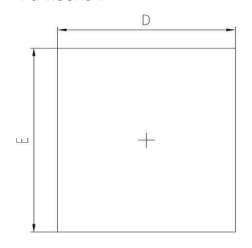


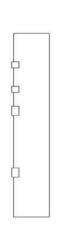


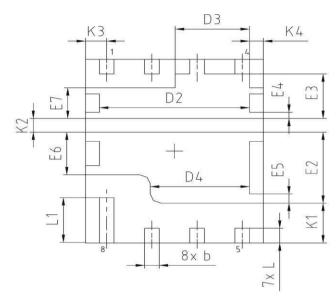


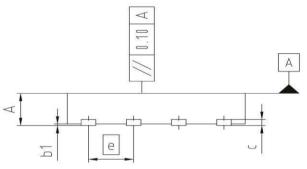
Package Outline

PG-TISON8-4

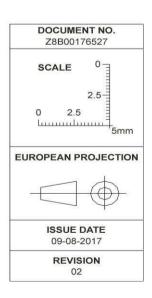








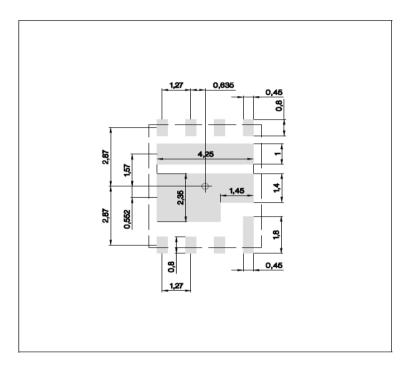
DIM	MILLIN	IETERS	INC	HES
DIIVI	MIN	MAX	MIN	MAX
Α	0.90	1.15	0.035	0.045
b	0.31	0.51	0.012	0.020
b1	0.00	0.05	0.000	0.002
С	0.10	0.30	0.004	0.012
D	4.90	5.10	0.193	0.201
D2	4.12	4.32	0.162	0.170
D3	1.99	2.19	0.078	0.086
D4	2.69	2.89	0.106	0.114
E	5.90	6.10	0.232	0.240
E2	2.22	2.42	0.087	0.095
E3	1.35	1.55	0.053	0.061
E4	0.10	0.30	0.004	0.012
E5	0.20	0.40	0.008	0.016
E6	1.29	1.49	0.051	0.059
E7	0.90	1.10	0.035	0.043
е	1.27	(BSC)	0.05	(BSC)
N		8	1	В
L	0.38	0.58	0.015	0.023
L1	1.38	1.58	0.054	0.062
K1	1.38	1.58	0.054	0.062
K2	0.35	0.55	0.014	0.022
K3	0.50	0.70	0.020	0.028
K4	0.29	0.49	0.011	0.019



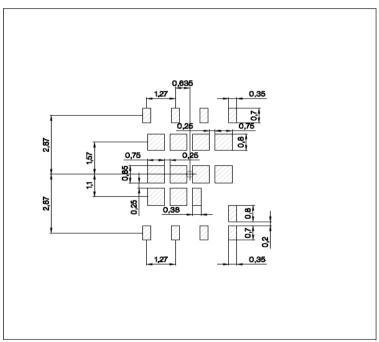


Boardpads & Apertures

PG-TISON8-4



copper



stencil apertures
All the dimensions in mm

25V OptiMOS™5 Power MOSFET

BSG0811ND



Revision History

BSG0811ND

Revision: 2017-08-25, Rev. 2.2

Previous Revision

Revision	Date	ubjects (major changes since last revision)			
2.0	2015-03-17	Release of final version			
2.1	2016-03-24	Update package drawing			
2.2	2017-08-25	Update package outline			

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